

5V, 300mA Linear Regulator with **RESET** and **ENABLE**

Description

The CS-8120 is a 5V, 300mA precision linear regulator with two microprocessor compatible control functions and protection circuitry included on chip. The composite NPN-PNP output pass transistor assures a lower dropout voltage (1V @ 200mA) without requiring excessive supply current (2.5mA).

The CS-8120's two logic control functions make this regulator well suited to applications requiring microprocessorbased control at the board or module level. ENABLE controls the output stage. A high voltage (>2.9V) on the ENABLE lead turns off the regulator's pass transistor and sends the IC into Sleep mode where it draws only 250μ A. The RESET function sends a

RESET signal when the IC is powering up or whenever the output voltage moves out of regulation. The RESET signal is valid down to $V_{OUT} = 1V$.

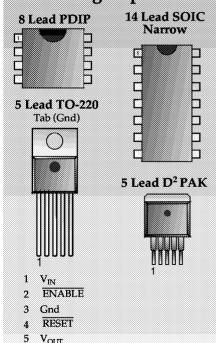
The CS-8120 design optimizes supply rejection by switching the internal bandgap reference from the supply input to the regulator output as soon as the nominal output voltage is achieved. Additional on chip filtering enhances rejection of high frequency transients on all external leads.

The CS-8120 is fault protected against short circuit, over voltage and thermal runaway conditions.

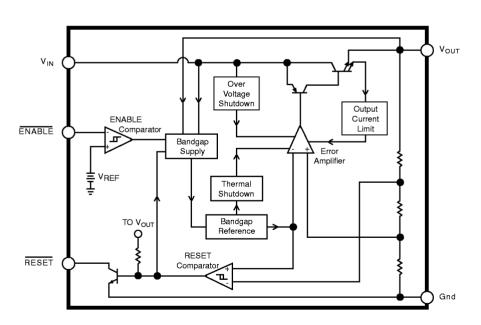
Features

- 5V ± 4% Output Voltage 300mA
- Low Dropout Voltage (1V @ 150mA)
- Low Quiescent Current $(2.5 \text{mA} @ I_{OUT} = 150 \text{mA})$
- μP Compatible Control **Functions** RESET ENABLE
- Low Current Sleep Mode $I_O=250\mu A$
- **Fault Protection** Thermal Shutdown Short Circuit 60V Load Dump

Package Options



Block Diagram



^{*} TO-220 Block Diagram



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 v_{out}

Absolute Maximum Ratings

| DC Input Voltage | 0.7 to 26V |
|--|------------------------------------|
| Load Dump | 60V |
| Output Current | Internally Limited |
| Electrostatic Discharge (Human Body Model) | |
| Operating Temperature | |
| Junction Temperature | 40°C to +150°C |
| Storage Temperature | |
| Lead Temperature Soldering | |
| Wave Solder (through hole styles only) | |
| Reflow (SMD styles only)60 | 0 sec. max above 183°C, 230°C peak |

| PARAMETER | TEST CONDITIONS | MIN | 157 | 107494 | (0)/111 |
|--|--|------|-------------------------|-------------------------|----------|
| Output Stage | | | | | |
| Output Voltage, V _{OUT} | $7V \le V_{IN} \le 26V$, $1mA \le I_{OUT} \le 300mA$ | 4.8 | 5.0 | 5.2 | V |
| Line Regulation | $7V \le V_{IN} \le 26V$, $I_{OUT} = 200$ mA | | | 50 | mV |
| Load Regulation | $1mA \le I_{OUT} \le 300mA$ | | | 50 | mV |
| Supply Voltage Rejection | $V_{IN} = 14VDC + 1_{VRMS}$ @120Hz, $I_{LOAD} = 25\Omega$ | 40 | 70 | | dB |
| Dropout Voltage | $I_{OUT} = 200 \text{mA}$ | | 1.0 | 1.5 | V |
| Quiescent Current | $\frac{\text{ENABLE}}{\text{ENABLE}} = \text{High, V}_{\text{IN}} = 12\text{V}$ $\overline{\text{ENABLE}} = \text{Low, I}_{\text{OUT}} = 200\text{mA}$ | | 0.25 2.5 | 0.65 15.0 | mA mA |
| Protection Circuits | | | | | |
| Short Circuit Current | | 300 | 600 | | mA |
| Thermal Shutdown | | 150 | 190 | | °C |
| Overvoltage Shutdown | | 26 | 40 | | V |
| RESET | | | | | |
| RESET Saturation Voltage | $1V < V_{OUT} < V_{RT(OFF)}$ 3.1k Ω pull-up to V_{OUT} | | 0.1 | 0.4 | V |
| RESET Output Leakage | ENABLE = Low | | 0 | 25 | μA |
| Current | $V_{\text{OUT}} > V_{\text{RT(ON)}}, V_{\overline{\text{RESET}}} = V_{\text{OUT}}$ | | | | |
| Power ON/OFF RESET Peak Output Voltage | $3.1k\Omega$ pull-up to V_{OUT} | | 0.7 | 1.0 | V |
| RESET Threshold ON (V _{OUT} Increasing) | | | V _{OUT} - 0.10 | V _{OUT} - 0.04 | V |
| RESET Threshold OFF (V _{OUT} Decreasing) | | 4.75 | V _{OUT} - 0.14 | | V |
| RESET Threshold Hysteresis | | 10 | 40 | | mV |
| ENABLE | | | | | |
| Input High Voltage | 7V < V _{IN} < 26V | | 2.9 | 3.9 | V |
| Input Low Voltage | $7V < V_{IN} < 26V$ | 1.1 | 2.1 | | V |
| Input Hysteresis | $7V < V_{IN} < 26V$ | 0.4 | 0.8 | 2.8 | V |
| Input Current | $Gnd < V_{IN(HI)} < V_{OUT}$ | -10 | 0 | +10 | μΑ |

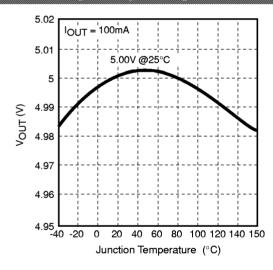
 $^{^{\}star}$ To have safe operating junction temperatures, low duty cycle pulse testing is used on tests where applicable.

Package Lead Description

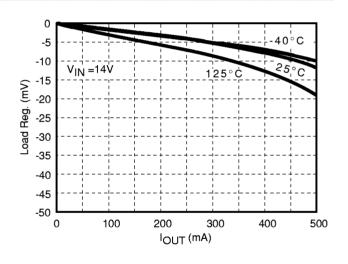
| PA | 81.07.001:01 | 9417 | | 887488397776 | FUNCTION |
|------------------|----------------|----------------------|------------------------------|--------------------|---|
| 5 Lead TO-220 | 8 Lead PDIP | 14 Lead SO Narrow | 5 Lead D ² PAK | | |
| 1 | 2 | 1 | 1 | V_{IN} | Supply voltage to IC, usually direct from the battery. |
| 2 | 4 | 5 | 2 | ENABLE | CMOS compatible logical input. V_{OUT} is disabled i.e. placed in a high impedance state when \overline{ENABLE} is high. |
| 3 | 8 | 13 | 3 | Gnd | Ground connection. |
| 4 | 6 | 10 | 4 | RESET | CMOS compatible output lead. \overline{RESET} goes low whenever V_{OUT} falls out of regulation. The \overline{RESET} delay is externally programmed. |
| 5 | 1 | 14 | 5 | V_{OUT} | Regulated output voltage, 5V (typ). |
| N/A | 7 | 12 | | SENSE | Kelvin Connection which allows remote sensing of output voltage for improved regulation. If remote sensing is not desired, connect to $V_{\rm OUT}$. |
| | 3, 5 | 2,3,4, | | NC | No connection |
| | | 6,7,8,9,11 | | | |

Typical Performance Characteristics

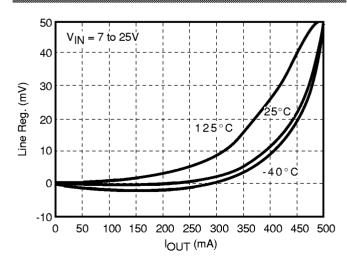
Ouron Voltage ve Temperature



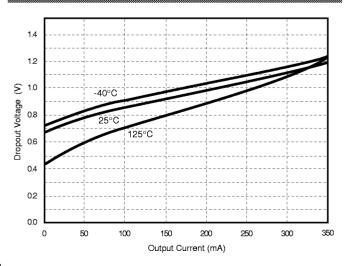
Load Regulation vs. Output Current Over Temperature



Line Regulation vs. Output Current Over Temperature



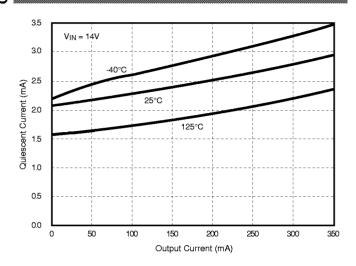
Dropoul Voltage vs. Output Current Over Temperature

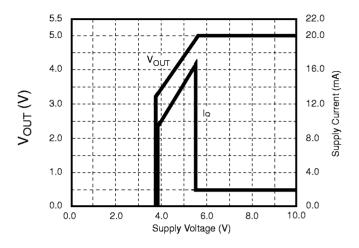


Typical Performance Characteristics: continued

Quiescent Current vs. Output Current Over Temperature

Oniput Voltage and Supply Current vs. Input Voltage





RESERVOUS Voltage vs. Output Content 2000 1800 $V_{IN} = 5V$ 1600 Reset Output Voltage (mV) 1400 1200 1000 800 600 400 200 5 40 Reset Output Current (mA)

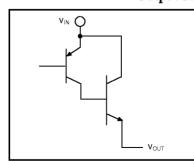
Circuit Description

Voltage Reference and Ontput Circular

Precision Voltage Reference

The regulated output voltage depends on the precision band gap voltage reference in the IC. By adding an error amplifier into the feedback loop , the output voltage is maintained within $\pm 4\%$ over temperature and supply variation.

Output Stage



The composite PNP-NPN output structure (Figure 1) provides 300mA (typ) of output current while maintaining a low drop out voltage (1.00V, typ) and drawing little quiescent current (2.5mA).

Figure 1: Composite Output Stage of the CS-8120

The NPN pass device prevents deep saturation of the output stage which in turn improves the IC's efficiency by preventing excess current from being used and dissipated by the IC.

Output Stage Protection

The output stage is protected against overvoltage, short circuit and thermal runaway conditions (Figure 2).

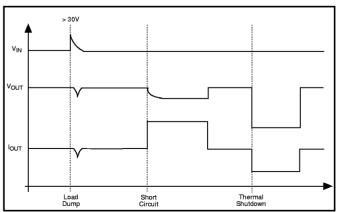


Figure 2: Typical Circuit Waveforms for Output Stage Protection.

Circuit Description: continued

If the input voltage rises above 26V (e.g. load dump), the output shuts down. This response protects the internal circuitry and enables the IC to survive unexpected voltage transients.

Using an emitter sense scheme, the amount of current through the NPN pass transistor is monitored. Feedback circuitry insures that the output current never exceeds a preset limit.

Should the junction temperature of the power device exceed 180°C (typ) the power transistor is turned off. Thermal shutdown is an effective means to prevent die overheating since the power transistor is the principle heat source in the IC.

Regulator Control Punctions

The CS-8120 contains two microprocessor compatible control functions: ENABLE and RESET (Figure 3).

ENABLE Function

ENABLE switches the output transistor. When the voltage on the ENABLE lead exceeds 2.9V typ, the output pass transistor turns off, leaving a high impedance facing the load. The IC will remain in Sleep mode, drawing only $250\mu A$, until the voltage on the lead drops below 2.1V typ. Hysteresis (800mV) is built into the ENABLE function to

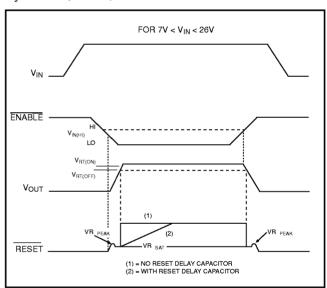


Figure 3: Circuit Waveforms for CS-8120

provide good noise immunity.

RESET Function

A \overline{RESET} signal (low voltage) is generated as the IC powers up (V_{OUT} > V_{OUT} - 100mV) or when V_{OUT} drops out of regulation (V_{OUT} < V_{OUT} - 140mV, typ). 40mV of hysteresis is included in the function to minimize oscillations.

The RESET output is an open collector NPN transistor, controlled by a low voltage detection circuit. The circuit is functionally independent of the rest of the IC, thereby

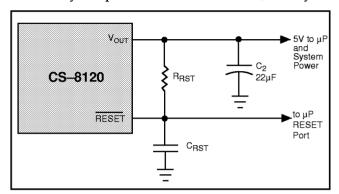


Figure 4: RC Network for RESET Delay circuitry

guaranteeing that the \overline{RESET} signal is valid for V_{OUT} as low as 1V.

An external RC network on the RESET lead (Figure 4) provides a sufficiently long delay for most microprocessor based applications. RC values can be chosen using the following formula:

$$\begin{bmatrix} & & \\ R_{TOT} \times C_{RST} & & \\ & & -t_{Delay} \\ \\ \ln & & \frac{V_T - V_{OUT}}{V_{RST} - V_{OUT}} \end{bmatrix}$$

where:

 $R_{TOT} = R_{RST}$ in parallel with R_{IN} .

 $R_{IN} = \mu P$ port impedance,

 $C_{RST} = \overline{RESET}$ delay capacitor,

t_{Delay} = desired delay time,

 $V_{RST} = V_{SAT}$ of \overline{RESET} lead

(0.7V @ turn - on), and

 $V_T = \mu P$ logic threshold voltage.

Applications Notes

The circuit depicted in Figure 5 lets the microprocessor control its power source, the CS-8120 regulator. An I/O port on the μ P and the SWITCH port are used to drive the base of Q1. When Q1 is driven into saturation, the voltage on the $\overline{\text{ENABLE}}$ lead falls below its lower threshold. The regulator's output is switched out. When the drive current is removed, the voltage on the $\overline{\text{ENABLE}}$ lead rises, the output is switched off and the IC moves into Sleep mode where it draws 250 μ A.

By coupling these two controls with \overline{ENABLE} , the system has added flexibility. Once the system is running, the state of the SWITCH is irrelevant as long as the I/O port continues to drive Q1. The μP can turn off its own power

by withdrawing drive current, once the SWITCH is open. This software control at the I/O port allows the μP to finish key housekeeping functions before power is removed.

The logic options are summarized in Table 1 below

| Table 1: Logic Control of CS-8120 Output | | | | |
|--|--------|---------------|--------|--|
| μΡΙ/O drive | SWITCH | ENABLE | Output | |
| ON | Closed | LOW | ON | |
| | Open | LOW | ON | |
| OFF | Closed | LOW | ON | |
| | Open | HIGH | OFF | |

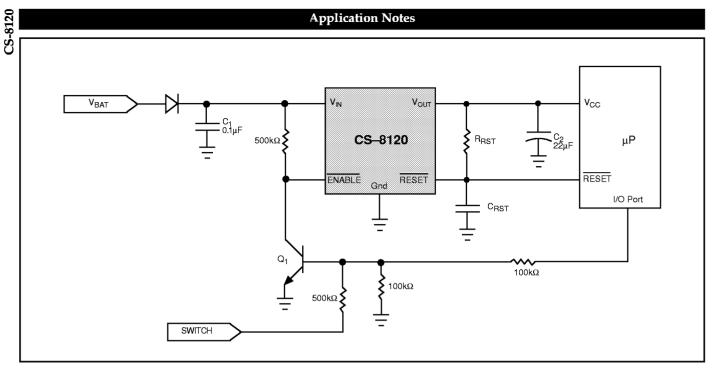


Figure 5: Microprocessor Control of CS-8120 using an external switching transistor (Q1).

The I/O port of the microprocessor typically provides $50\mu\text{A}$ to Q1. In automotive applications the SWITCH is connected to the ignition switch.

Sability Considerations

The output or compensation capacitor, C_2 , helps determine three main characteristics of a linear regulator: startup delay, load transient response and loop stability.

The capacitor value and type should be based on cost, availability, size and temperature constraints. A tantalum or aluminum electrolytic capacitor is best, since a film or ceramic capacitor with almost zero ESR can cause instability. The aluminum electrolytic capacitor is the least expensive solution, but, if the circuit operates at low temperatures (-25°C to -40°C), both the value and ESR of the capacitor will vary considerably. The capacitor manufacturers data sheet usually provides this information.

The value for the output capacitor C_2 shown in Figure 6 should work for most applications, however it is not necessarily the optimized solution.

To determine an acceptable value for C_2 for a particular application, start with a tantalum capacitor of the recommended value and work towards a less expensive alternative part.

Step 1: Place the completed circuit with a tantalum capacitor of the recommended value in an environmental chamber at the lowest specified operating temperature and monitor the outputs with an oscilloscope. A decade box connected in series with the capacitor will simulate the higher ESR of an aluminum capacitor. Leave the decade box outside the chamber, the small resistance added by the longer leads is negligible.

Step 2: With the input voltage at its maximum value, increase the load current slowly from zero to full load while observing the output for any oscillations. If no oscillations are observed, the capacitor is large enough to ensure a stable design under steady state conditions.

Step 3: Increase the ESR of the capacitor from zero using the decade box and vary the load current until oscillations appear. Record the values of load current and ESR that cause the greatest oscillation. This represents the worst case load conditions for the regulator at low temperature.

Step 4: Maintain the worst case load conditions set in step 3 and vary the input voltage until the oscillations increase. This point represents the worst case input voltage conditions.

Step 5: If the capacitor is adequate, repeat steps 3 and 4 with the next smaller valued capacitor. A smaller capacitor will usually cost less and occupy less board space. If the output oscillates within the range of expected operating conditions, repeat steps 3 and 4 with the next larger standard capacitor value.

Step 6: Test the load transient response by switching in various loads at several frequencies to simulate its real working environment. Vary the ESR to reduce ringing.

Step 7: Remove the unit from the environmental chamber and heat the IC with a heat gun. Vary the load current as instructed in step 5 to test for any oscillations.

Once the minimum capacitor value with the maximum ESR is found, a safety factor should be added to allow for the tolerance of the capacitor and any variations in regulator performance. Most good quality aluminum electrolytic capacitors have a tolerance of \pm 20% so the minimum value found should be increased by at least 50% to allow for this tolerance plus the variation which will occur at low temperatures. The ESR of the capacitor should be less than 50% of the maximum allowable ESR found in step 3 above.

Application Notes: continued

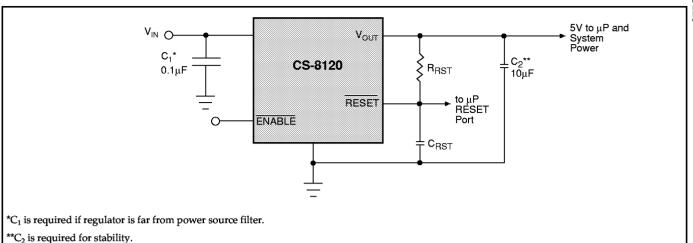


Figure 6. Circuit showing output compensation capacitor.

Calculating Power Dissipation in a Single Output Linear Regulator

The maximum power dissipation for a single output regulator (Figure 7) is:

$$P_{D(max)} = [V_{IN(max)} - V_{OUT(min)}]I_{OUT(max)} + V_{IN(max)}I_{O}$$
 (1)

where:

 $V_{IN(max)}$ is the maximum input voltage,

 $V_{OUT(min)}$ is the minimum output voltage,

 $I_{OUT\left(max\right)}$ is the maximum output current for the application, and

 I_Q is the quiescent current the regulator consumes at $I_{\text{OUT}(\text{max})}.$

Once the value of $P_{D(max)}$ is known, the maximum permissible value of $R_{\Theta JA}$ can be calculated:

$$R_{\Theta JA} = \frac{150^{\circ} \text{C - T}_{A}}{P_{D}} \tag{2}$$

The value of $R_{\Theta JA}$ can then be compared with those in the package section of the data sheet. Those packages with $R_{\Theta JA}$'s less than the calculated value in equation 2

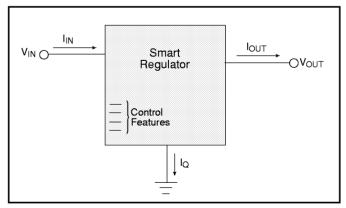


Figure 7. Single output regulator with key performance parameters labeled.

will keep the die temperature below 150°C.

In some cases, none of the packages will be sufficient to dissipate the heat generated by the IC, and an external heatsink will be required.

Heal Sinks

A heat sink effectively increases the surface area of the package to improve the flow of heat away from the IC and into the surrounding air.

Each material in the heat flow path between the IC and the outside environment will have a thermal resistance. Like series electrical resistances, these resistances are summed to determine the value of $R_{\Theta IA}$:

$$R_{\Theta IA} = R_{\Theta IC} + R_{\Theta CS} + R_{\Theta SA} \tag{3}$$

where:

 $R_{\Theta IC}$ = the junction-to-case thermal resistance,

 $R_{\Theta CS}$ = the case-to-heatsink thermal resistance, and

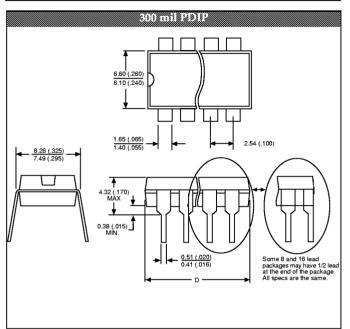
 $R_{\Theta SA}$ = the heatsink–to–ambient thermal resistance.

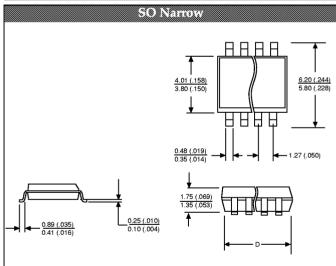
 $R_{\Theta JC}$ appears in the package section of the data sheet. Like $R_{\Theta JA}$, it too is a function of package type, $R_{\Theta CS}$ and $R_{\Theta SA}$ are functions of the package type, heatsink and the interface between them. These values appear in heat sink data sheets of heat sink manufacturers.

Package Specification

PACEACE DIMENSIONS IN 1999 (INCHES)

| | D | | | |
|---------------------|--------|------|---------|------|
| Lead Count | Metric | | English | |
| | Max | Min | Max | Min |
| 14 Lead SOIC Narrow | 8.74 | 8.53 | .344 | .336 |
| 8 Lead PDIP | 9.40 | 9.14 | .370 | .360 |

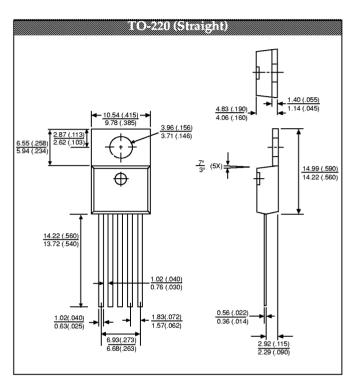


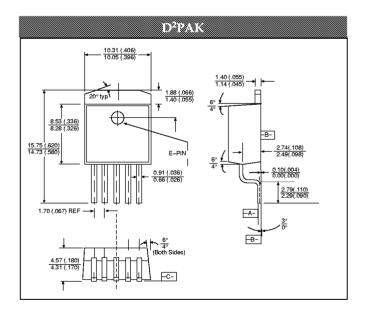


| 810000000000000000000000000000000000000 | |
|---|---------|
| | Descrin |

| Part Number | Description |
|-------------|------------------------------------|
| CS-8120T5 | 5 Lead TO-220 Straight |
| CS-8120TV5 | 5 Lead TO-220 Vertical |
| CS-8120TH5 | 5 Lead TO-220 Horizontal |
| CS-8120N8 | 8 Lead PDIP |
| CS-8120DP5 | 5 Lead D ² PAK |
| CS-8120D14 | 14 Lead SOIC Narrow |
| CS-8120DR14 | 14 Lead SOIC Narrow Tape & Reel |

| Thern | Thermal Data 5 Lead 5 Lead 8 Lead 14 Lead S TO-220 D ² Pak PDIP Narro | | N | | | |
|--|---|-----|--------|-----|-----|------|
| $R_{\Theta JC}$ | typ | 3.1 | 3.1 | 52 | 30 | °C/W |
| $R_{\Theta JA}$ | typ | 50 | 10-50* | 100 | 125 | °C/W |
| *Depending on thermal properties of substrate Roy, Roya Roya | | | | | | |





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